

Features

- Easy to use, compatible with standard gate drivers
- Low Q_{rr} , no free-wheeling diode required
- Excellent $Q_g \times R_{DS(on)}$ product (FOM)
- Low switching loss
- RoHS compliant and Halogen-free

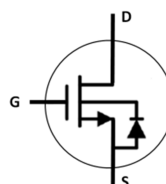
Application

- Power adapters
- Telecom and datacom
- Automotive
- Servo motors

Product Summary



V_{DS}	650	V
$R_{DS(on),Max} @ V_{GS}=8V$	150	mΩ
I_D	18	A



Maximum ratings, at $T_C=25^\circ\text{C}$, unless otherwise specified

Symbol	Parameter		Limit Value	Unit
I_D	Continuous drain current @ $T_C=25^\circ\text{C}$		18	A
	Continuous drain current @ $T_C=100^\circ\text{C}$		11.5	A
I_{DM}	Pulsed drain current @ $T_C=25^\circ\text{C}$ (pulse width: 10us)		80	A
	Pulsed drain current @ $T_C=150^\circ\text{C}$ (pulse width: 10us)		58	A
V_{DSS}	Drain to source voltage ($T_J = -55^\circ\text{C}$ to 150°C)		650	V
V_{TDSS}	Transient drain to source voltage ^a		800	V
V_{GSS}	Gate to source voltage		± 20	V
P_D	Maximum power dissipation @ $T_C=25^\circ\text{C}$		67.5	W
T_C	Operating temperature	Case	-55 to 150	$^\circ\text{C}$
T_J		Junction	-55 to 150	$^\circ\text{C}$
T_S	Storage temperature		-55 to 150	$^\circ\text{C}$
T_{CSOLD}	Soldering peak temperature		260	$^\circ\text{C}$

Thermal Resistance

Symbol	Parameter	Typical	Unit
$R_{\theta JC}$	Junction-to-case	1.85	$^\circ\text{C/W}$
$R_{\theta JA}$	Junction-to-ambient ^b	50	$^\circ\text{C/W}$

Notes:

- Off-state spike duty cycle < 0.01 , spike duration $< 2\mu\text{s}$
- Device on one layer epoxy PCB for drain connection (vertical and without air stream cooling, with 6cm^2 copper area and $70\mu\text{m}$ thickness)

Electrical Parameters, at $T_J=25^\circ\text{C}$, unless otherwise specified

Symbol	Min	Typ	Max	Unit	Test Conditions
Forward Characteristics					
V _{DSS-MAX}	650	-	-	V	V _{GS} =0V
V _{GS(th)}	3.5	-	4.5	V	V _{DS} =V _{GS} , I _D =500μA
R _{DS(on)} ^c	-	-	150	mΩ	V _{GS} =8V, I _D =4A, T _J =25°C
	-	240	-		V _{GS} =8V, I _D =4A, T _J =150°C
I _{DSS}	-	5	20	μA	V _{DS} =700V, V _{GS} =0V, T _J =25°C
	-	50	-	μA	V _{DS} =700V, V _{GS} =0V, T _J =150°C
I _{GSS}	-	-	150	nA	V _{GS} =20V
	-	-	-150	nA	V _{GS} =-20V
C _{ISS}	-	606	-	pF	V _{GS} =0V, V _{DS} =650V, f=1MHz
C _{OSS}	-	40	-	pF	
C _{RSS}	-	3	-	pF	
C _{O(er)}	-	25	-	pF	V _{GS} =0V, V _{DS} =0 - 650V
C _{O(tr)}	-	45	-	pF	
Q _G	-	38	-	nC	V _{DS} =400V, V _{GS} =0 - 12V, I _D =10A
Q _{GS}	-	8.4	-		
Q _{GD}	-	4.7	-		
t _{D(on)}	-	44	-	ns	V _{DS} =400V, V _{GS} =0 - 12V, I _D =10A, R _G =40Ω
t _R	-	16	-		
t _{D(off)}	-	40	-		
t _F	-	12	-		
Reverse Characteristics					
V _{SD}	-	1.3	-	V	V _{GS} =0V, I _S =5A, T _J =25°C
	-	1.9	-		V _{GS} =0V, I _S =10A, T _J =25°C
	-	3	-		V _{GS} =0V, I _S =10A, T _J =150°C
t _{RR}	-	16	-	ns	I _S =10A, V _{GS} =0V, d _i /d _t =1000A/us, V _{DD} =400V
Q _{RR}	-	26	-	nC	

Notes:

c. Dynamic on-resistance; see Figure 17 and 18 for test circuit and configurations

Typical Characteristics, at $T_c=25^\circ\text{C}$, unless otherwise specified

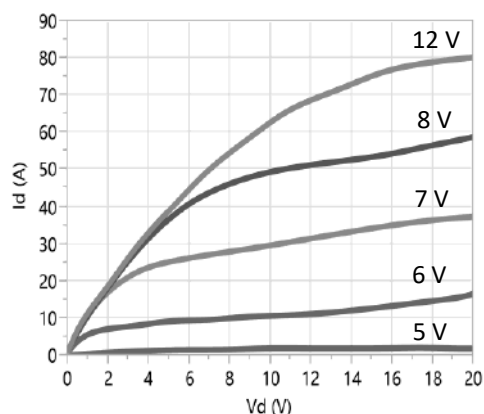


Figure 1. Typical Output Characteristics $T_j=25^\circ\text{C}$

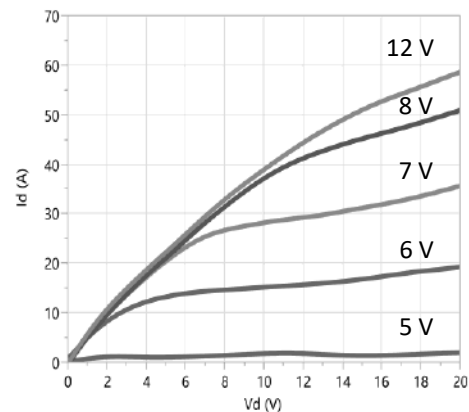


Figure 2. Typical Output Characteristics $T_j=150^\circ\text{C}$

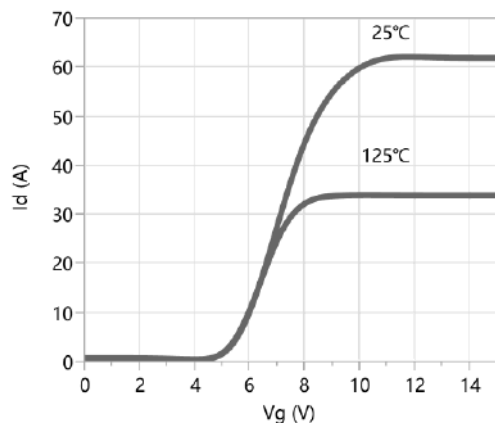


Figure 3. Typical Transfer Characteristics

$V_{DS}=10\text{V}$, Parameter: T_j

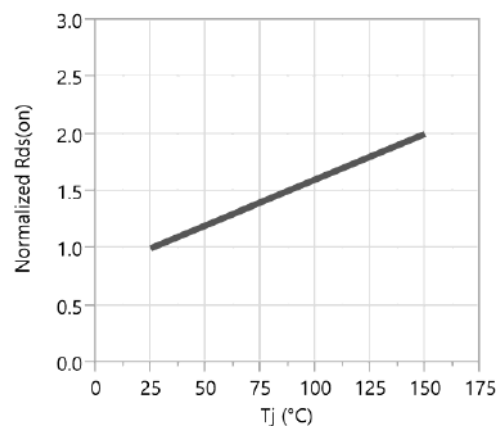


Figure 4. Normalized On-resistance

$I_D=4\text{A}$, $V_{GS}=12\text{V}$

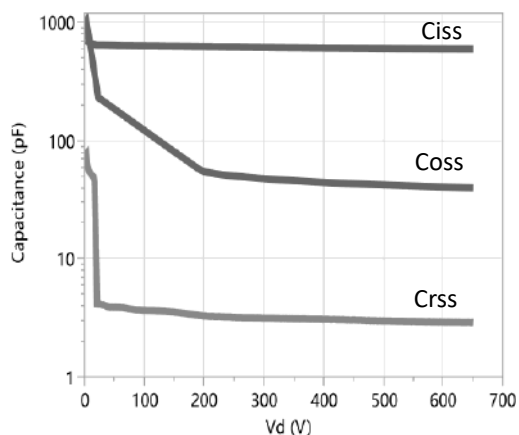


Figure 5. Typical Capacitance

$V_{GS}=0\text{V}$, $f=1\text{MHz}$

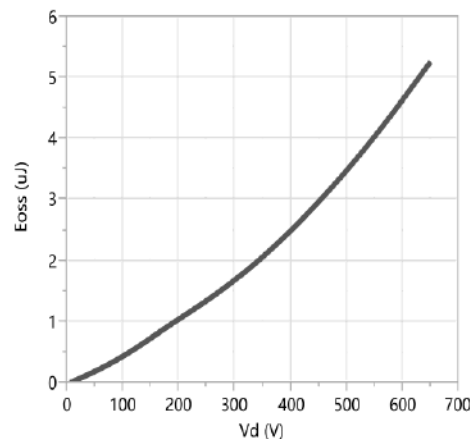


Figure 6. Typical C_{oss} Stored Energy

Typical Characteristics, at $T_c=25^\circ\text{C}$, unless otherwise specified

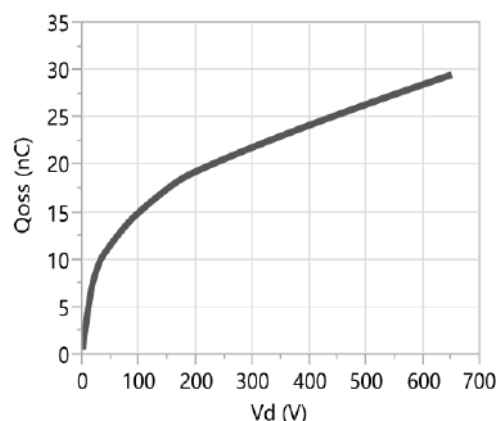


Figure 7. Typical Qoss

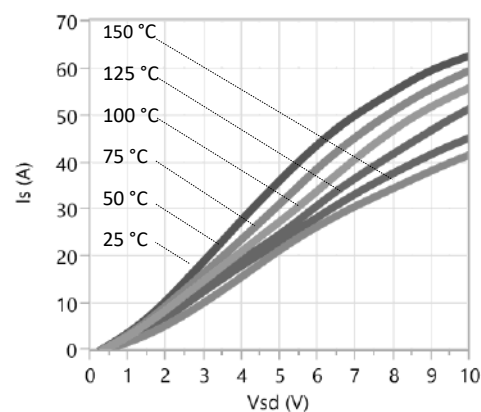


Figure 8. Forward Characteristic of Rev. Diode

$I_s=f(V_{sd})$, Parameter: T_j

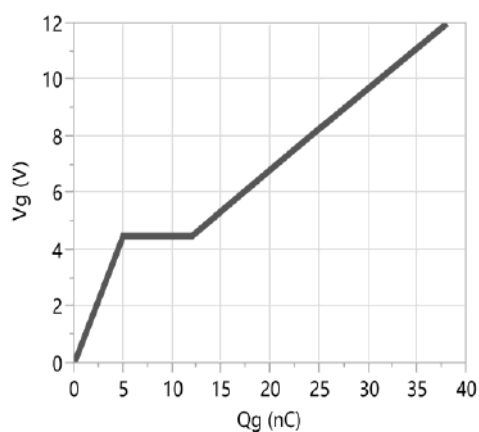


Figure 9. Typical Gate Charge

$I_{DS}=10\text{A}$, $V_{DS}=400\text{V}$

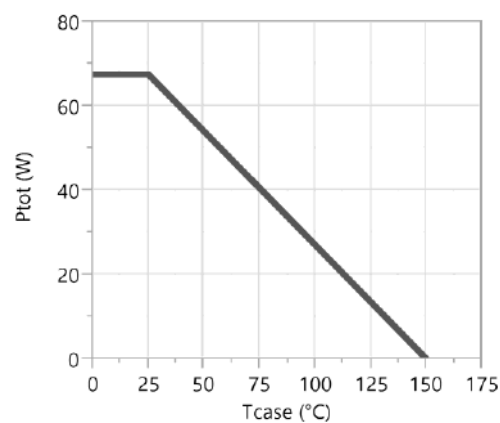


Figure 10. Power Dissipation

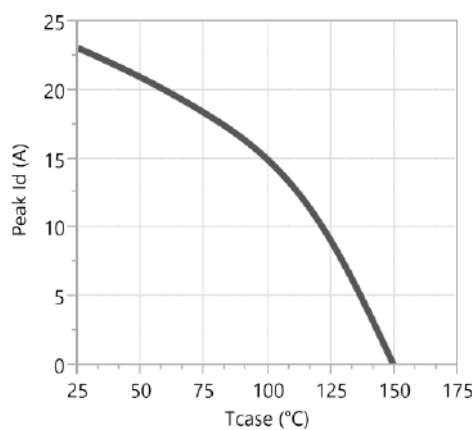


Figure 11. Current Derating

Typical Characteristics, at $T_c=25^\circ\text{C}$, unless otherwise specified

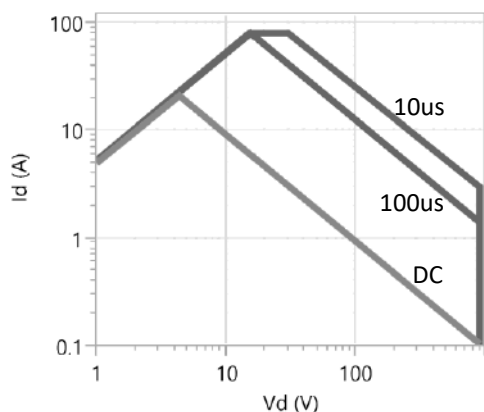


Figure 12. Safe operating Area $T_c=25^\circ\text{C}$

(calculated based on thermal limits)

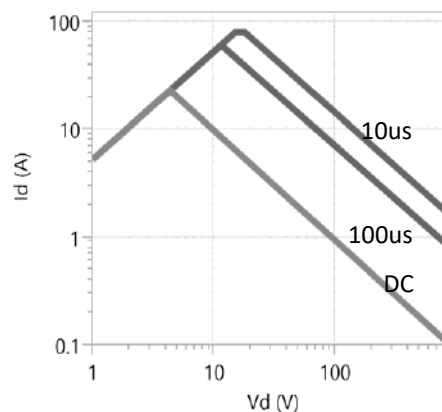


Figure 13. Safe operating Area $T_c=80^\circ\text{C}$

(calculated based on thermal limits)

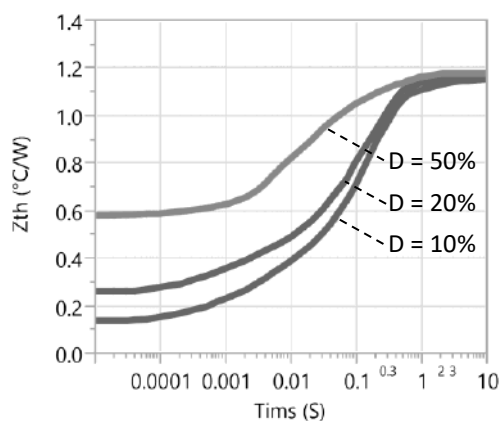
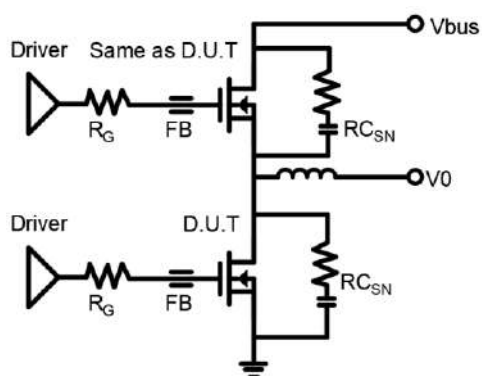


Figure 14. Transient Thermal Resistance

Circuit Implementation



Recommended Single Ended Drive Circuit

Test Circuits and Waveforms

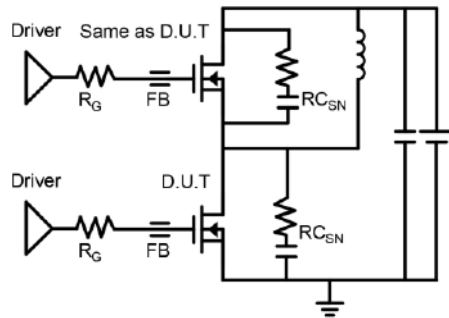


Figure 15. Switching Time Test Circuit

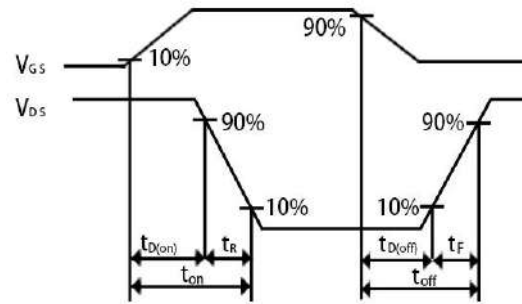


Figure 16. Switching Time Waveform

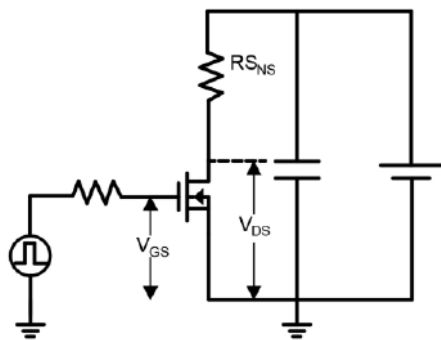


Figure 17. Dynamic $R_{DS(on)}$ Test Circuit

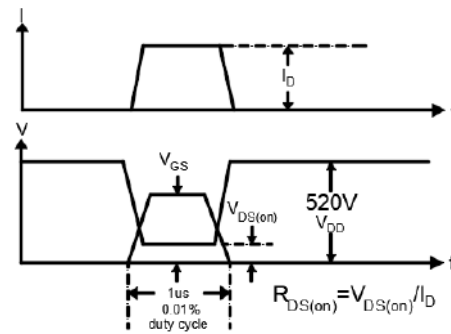


Figure 18. Dynamic $R_{DS(on)}$ Waveform

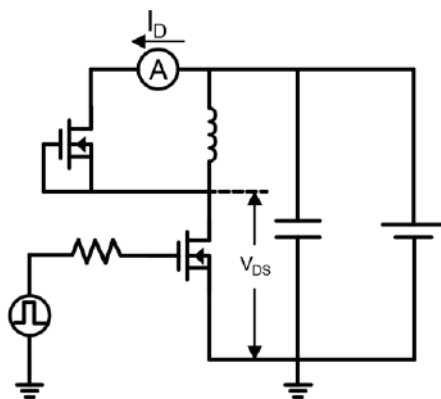


Figure 19. Diode Characteristic Test Circuit

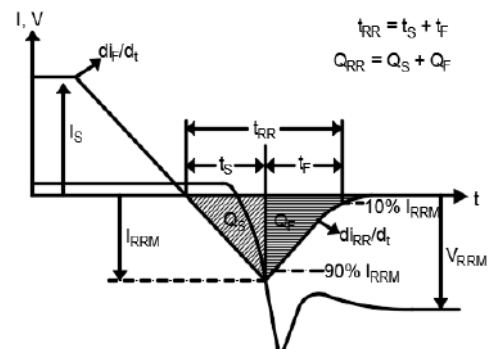


Figure 20. Diode Recovery Waveform

Design Considerations

Fast switching GaN device can reduce power conversion losses, and thus enable high frequency operations. Certain PCB design rules and instructions, however, need to be followed to take full advantages of fast switching GaN devices.

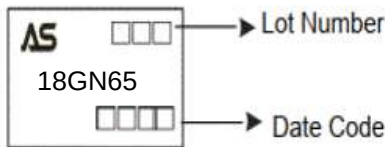
Before evaluating Runxin Micro's GaN devices, please refer to the table below which provides some practical rules that should be followed during the evaluation.

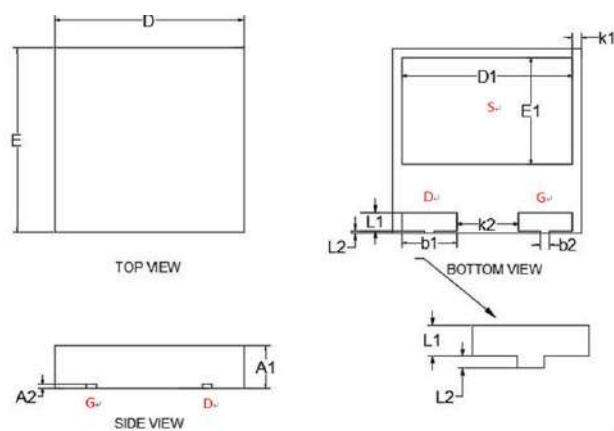
When Evaluating Runxin Micro's GaN Devices:

DO	DO NOT
Make sure the traces are as short as possible for both drive and power loops to minimize parasitic inductance	Using Runxin Micro's devices in GDS board layouts
Use the test tool with the shortest inductive loop, and make sure test points should be placed close enough	Use differential mode probe or probe ground clip with long wires
Minimize the lead length of TO packages when installing them to PCB	Use long traces in drive circuit, or long lead length of the devices

Ordering and Marking Information

Ordering Device No.	Marking	Package	Packing	Quantity
ASDM18GN65TE-R	18GN65	DFN8*8	Tape&Reel	5000/Reel

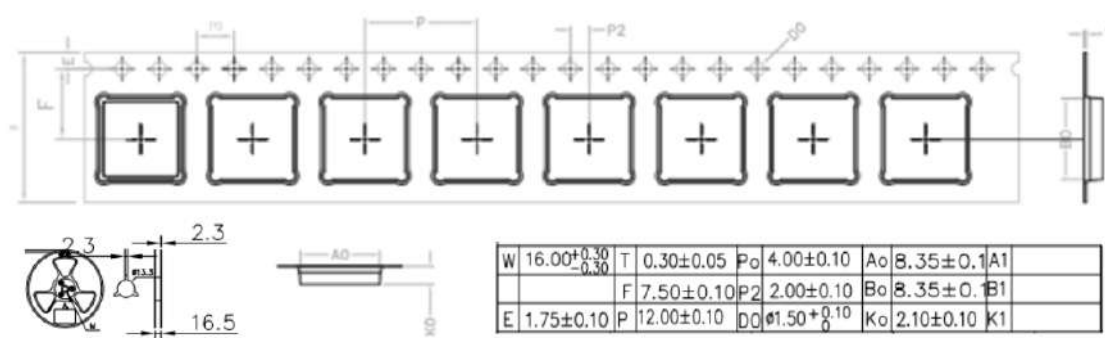
PACKAGE	MARKING
DFN8*8	

Package Outline

DFN 8 x 8mm (HS) Package

Symbol	Dimensions in Millimeters		
	MIN	NOM	MAX
A1	0.850	0.900	0.950
A2	0.185	0.203	0.230
D	7.000	8.000	9.000
E	7.950	8.000	8.050
D1	7.050	7.200	7.350
E1	4.450	4.600	4.750
K1	0.375	0.400	0.425
K2	2.575	2.600	2.625
b1	2.250	2.300	2.350
b2	0.375	0.400	0.425
L1	0.700	0.800	0.900
L2	0.075	0.100	0.125

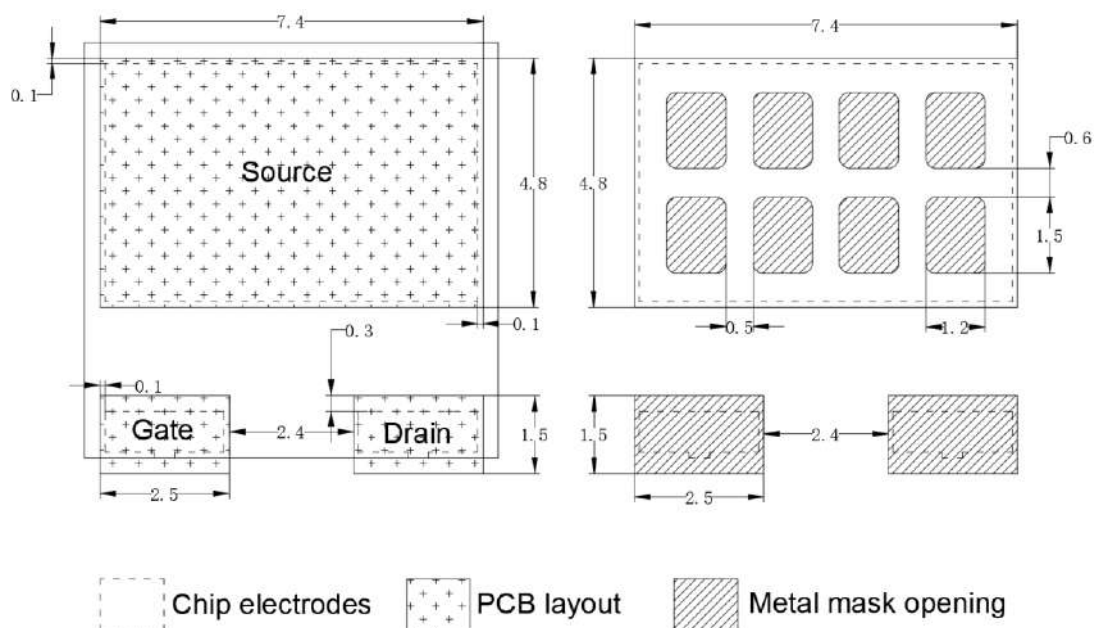
Tape and Reel Information

Dimensions are shown in millimeters



Recommended PCB Layout & Metal mask opening

Dimensions are shown in millimeters



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